UNITED STATES DEPARTMENT OF COMMERCE United States Patent and Trademark Office Address: COMMISSIONER FOR PATENTS P.O. Box 1450 Alexandria, Virginia 22313-1450

NOTICE OF ALLOWANCE AND FEE(S) DUE

8933 7590 01/20/2012 DUANE MORRIS LLP - Philadelphia IP DEPARTMENT 30 SOUTH 17TH STREET PHILADEL PHIA. PA 19103-4196 EXAMINER

LE, DUNG ANH

ART UNIT PAPER NUMBER

2818 DATE MAILED: 01/20/2012

APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/595,384	06/30/2008	Christopher Hess	D5116-00051	8498

TITLE OF INVENTION: METHOD AND CONFIGURATION FOR CONNECTING TEST STRUCTURES OR LINE ARRAYS FOR MONITORING INTEGRATED CIRCUIT MANUFACTURING

APPLN. TYPE	SMALL ENTITY	ISSUE FEE DUE	PUBLICATION FEE DUE	PREV. PAID ISSUE FEE	TOTAL FEE(S) DUE	DATE DUE
nonprovisional	NO	\$1740	\$300	\$0	\$2040	04/20/2012

THE APPLICATION IDENTIFIED ABOVE HAS BEEN EXAMINED AND IS ALLOWED FOR ISSUANCE AS A PATENT. PROSECUTION ON THE MERITS IS CLOSED. THIS NOTICE OF ALLOWANCE IS NOT A GRANT OF PATENT RIGHTS. THIS APPLICATION IS SUBJECT TO WITHDRAWAL FROM ISSUE AT THE INITIATIVE OF THE OFFICE OR UPON PETITION BY THE APPLICANT. SEE 37 CFR 1.313 AND MPEP 1308.

THE ISSUE FEE AND PUBLICATION FEE (IF REQUIRED) MUST BE PAID WITHIN THREE MONTHS FROM THE MAILING DATE OF THIS NOTICE OR THIS APPLICATION SHALL BE REGARDED AS ABANDONED. THIS STATUTORY PERIOD CANNOT BE EXTENDED. SEE 35 U.S.C. 1SI. THE ISSUE FEE DUE INDICATED ABOVE DOES NOT REFLECT A CREDIT FOR ANY PREVIOUSLY PAID ISSUE FEE IN THIS APPLICATION. IF AN ISSUE FEE HAS PREVIOUSLY BEEN PAID IN THIS APPLICATION (AS SHOWN ABOVE), THE RETURN OF PART B OF THIS FORM WILL BE CONSIDERED A REQUEST TO REAPPLY THE PREVIOUSLY PAID ISSUE FEE TOWARD THE ISSUE FEE NOW DUE.

HOW TO REPLY TO THIS NOTICE:

I. Review the SMALL ENTITY status shown above.

If the SMALL ENTITY is shown as YES, verify your current SMALL ENTITY status:

A. If the status is the same, pay the TOTAL FEE(S) DUE shown above.

B. If the status above is to be removed, check box 5b on Part B - Fee(s) Transmittal and pay the PUBLICATION FEE (if required) and twice the amount of the ISSUE FEE shown above, or

If the SMALL ENTITY is shown as NO:

A. Pay TOTAL FEE(S) DUE shown above, or

B. If applicant claimed SMALL ENTITY status before, or is now claiming SMALL ENTITY status, check box 5a on Part B - Fee(s) Transmittal and pay the PUBLICATION FEE (if required) and 1/2 the ISSUE FEE shown above.

IL PART B - FEE(S) TRANSMITTAL, or its equivalent, must be completed and returned to the United States Patent and Trademark Office (USPTO) with your ISSUE FEE and PUBLICATION FEE (if required). If you are charging the fee(s) to your deposit account, section "4b" of Part B - Fee(s) Transmittal should be completed and an extra copy of the form should be submitted. If an equivalent of Part B is filed, a request to reapply a previously paid issue fee must be clearly made, and delays in processing may occur due to the difficulty in recognizing the paper as an equivalent of Part B.

III. All communications regarding this application must give the application number. Please direct all communications prior to issuance to Mail Stop ISSUE FEE unless advised to the contrary.

IMPORTANT REMINDER: Utility patents issuing on applications filed on or after Dec. 12, 1980 may require payment of maintenance fees. It is patentee's responsibility to ensure timely payment of maintenance fees when due.

PART B - FEE(S) TRANSMITTAL

Complete and send this form, together with applicable fee(s), to: Mail Mail Stop ISSUE FEE Commissioner for Patents P.O. Box 1450 Alexandria, Virginia 22313-1450

or Fax (571)-273-2885

INSTRUCTIONS: This form should be used for transmitting the ISSUE FEE and PUBLICATION FEE (if required). Blocks 1 through 5 should be completed where appropriate. All further correspondence including the Patent, advance orders and notification of maintenance fees will be mailed to the current correspondence address; and indicated unless corrected below or directed otherwise in Block 1, by (a) specifying a new correspondence address; and/or bibliotic patentials of FEE ADDRESS* for maintenance fee notification

8933 01/20/2012 DUANE MORRIS LLP - Philadelphia

SMALL ENTITY

IP DEPARTMENT 30 SOUTH 17TH STREET

PHILADELPHIA, PA 19103-4196

APPLN. TYPE

Note: A certificate of mailing can only be used for domestic mailings of the Fee(s) Transmittal. This certificate cannot be used for any other accompanying papers. Each additional paper, such as an assignment or formal drawing, must have its own certificate of mailing or transmission.

Certificate of Mailing or Transmission

I hereby certify that this Feeds (Yanaling or 1 ransamssion)
I hereby certify that this Feeds (Yanasmittal is being deposited with the United States Postal Service with sufficient postage for first class mail in an envelope addressed to the Mail Stop ISSUE FEE address above, or being facsimile transmitted to the USPTO (5/11) 273-22885, on the date indicated below.

(Depositor's nam (Signate (Dat

TOTAL FEE(S) DUE

DATE DUE

APPLICATION NO. FILING DATE FIRST NAMED INVENTOR ATTORNEY DOCKET NO CONFIRMATION NO 10/595 384 06/30/2008 Christopher Hess D5116-00051 8498

PUBLICATION FEE DUE PREV. PAID ISSUE FEE

TITLE OF INVENTION: METHOD AND CONFIGURATION FOR CONNECTING TEST STRUCTURES OR LINE ARRAYS FOR MONITORING INTEGRATED CIRCUIT MANUFACTURING

ISSUE FEE DUE

nonprovisional	NO	\$1740	\$300	\$0	\$2040	04/20/2012	
EXAMINER		ART UNIT	CLASS-SUBCLASS				
LE, DUNG ANH 2818		2818	257-048000				
1. Change of correspondence address or indication of "Fee Address" (27 CFR 1.5d3). Change of correspondence address (or Change of Correspondence Address form PTOSB/12.2) attached. Tee Address form (or "Fee Address" Indication form PTOSB/47, Rev 03-02 or more recent) attached. Use of a Customer Number is required.			or agents OR, alternativ (2) the name of a single registered attorney or a	3 registered patent attorneys ely, e firm (having as a member a gent) and the names of up to meys or agents. If no name is	1 2 3		
3. ASSIGNEE NAME AND RESIDENCE DATA TO BE PRINTED ON THE PATENT (gring or type) PLEASE NOTE: Libes an assignee is identified below, no assignee cata will appear on the patent. If an assignee is identified below, the document has been filed for recordation as set forth in 37 CFR 3.11. Completion of this form is NOT a substitute for filing an assignment. (A) NAME OF ASSIGNEE (B) RESIDENCE: (CITY and STATE OR COUNTRY)							
Please check the appropriate assignee category or categories (will not be printed on the patent): 🔘 Individual 🚨 Corporation or other private group entity 🚨 Government							

4a. The following fee(s) are submitted: 4b. Payment of Fee(s): (Please first reapply any previously paid issue fee shown above) ☐ Issue Fee A check is enclosed. Dublication Fee (No small entity discount permitted) Payment by credit card. Form PTO-2038 is attached. The Director is hereby authorized to charge the required fee(s), any deficiency, or credit any overpayment, to Deposit Account Number (enclose an extra copy of this fo Advance Order - # of Copies (enclose an extra copy of this form).

5. Change in Entity Status (from status indicated above)

□ b. Applicant is no longer claiming SMALL ENTITY status. See 37 CFR 1.27(g)(2). a. Applicant claims SMALL ENTITY status. See 37 CFR 1.27. NOTE: The Issue Fee and Publication Fee (if required) will not be accepted from anyone other than the applicant; a registered attorney or agent; or the assignee or other party in interest as shown by the records of the United States Patent and Trademark Office

Authorized Signature Date Typed or printed name Registration No.

This collection of information is required by 37 CFR 1.311. The information is required to obtain or retain a benefit by the public which is to file (and by the USPTO to process) an application. Confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.14. This collection is estimated to take 12 minutes to complete, including gathering, preparing, and submitting the completed application form to the USPTO. Time will vary depending upon the individual case. Any comments on the amount of time you require to complete this form and/or suggestions for rectucing this burden, should be sent to the Chief Information Officer. U.S. Patest and Trademark Officer. U.S. Department of Commerce, P.O. Box 1450, Alexandria, Virginia 2231-450. DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS. SEND TO: Commissioner for Patents, P.O. Box 1450, Alexandria, Virginia 2231-450.

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PHILADELPHIA, PA 19103-4196

UNITED STATES PATENT AND TRADEMARK OFFICE

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DATE MAILED: 01/20/2012

2818

Determination of Patent Term Adjustment under 35 U.S.C. 154 (b)

(application filed on or after May 29, 2000)

The Patent Term Adjustment to date is 873 day(s). If the issue fee is paid on the date that is three months after the mailing date of this notice and the patent issues on the Tuesday before the date that is 28 weeks (six and a half months) after the mailing date of this notice, the Patent Term Adjustment will be 873 day(s).

If a Continued Prosecution Application (CPA) was filed in the above-identified application, the filing date that determines Patent Term Adjustment is the filing date of the most recent CPA.

Applicant will be able to obtain more detailed information by accessing the Patent Application Information Retrieval (PAIR) WEB site (http://pair.uspto.gov).

Any questions regarding the Patent Term Extension or Adjustment determination should be directed to the Office of Patent Legal Administration at (571)-272-7702. Questions relating to issue and publication fee payments should be directed to the Customer Service Center of the Office of Patent Publication at 1-(888)-786-0101 or (571)-272-4200.

Privacy Act Statement

The Privacy Act of 1974 (P.L. 93-579) requires that you be given certain information in connection with your submission of the attached form related to a patent application or patent. Accordingly, pursuant to the requirements of the Act, please be advised that: (1) the general authority for the collection of this information is 35 U.S.C. 2(b)(2); (2) furnishing of the information solicited is voluntary; and (3) the principal purpose for which the information is used by the U.S. Patent and Trademark Office is to process and/or examine your submission related to a patent application or patent. If you do not furnish the requested information, the U.S. Patent and Trademark Office may not be able to process and/or examine your submission, which may result in termination of proceedings or abandonment of the application or expiration of the patent.

The information provided by you in this form will be subject to the following routine uses:

- The information on this form will be treated confidentially to the extent allowed under the Freedom
 of Information Act (5 U.S.C. 552) and the Privacy Act (5 U.S.C 552a). Records from this system of
 records may be disclosed to the Department of Justice to determine whether disclosure of these
 records is required by the Freedom of Information Act.
- A record from this system of records may be disclosed, as a routine use, in the course of presenting evidence to a court, magistrate, or administrative tribunal, including disclosures to opposing counsel in the course of settlement neeotiations.
- 3. A record in this system of records may be disclosed, as a routine use, to a Member of Congress submitting a request involving an individual, to whom the record pertains, when the individual has requested assistance from the Member with respect to the subject matter of the record.
- 4. A record in this system of records may be disclosed, as a routine use, to a contractor of the Agency having need for the information in order to perform a contract. Recipients of information shall be required to comply with the requirements of the Privacy Act of 1974, as amended, pursuant to 5 U.S.C. 552a(m).
- 5. A record related to an International Application filed under the Patent Cooperation Treaty in this system of records may be disclosed, as a routine use, to the International Bureau of the World Intellectual Property Organization, pursuant to the Patent Cooperation Treaty.
- A record in this system of records may be disclosed, as a routine use, to another federal agency for purposes of National Security review (35 U.S.C. 181) and for review pursuant to the Atomic Energy Act (42 U.S.C. 218(c)).
- 7. A record from this system of records may be disclosed, as a routine use, to the Administrator, General Services, or his/her designee, during an inspection of records conducted by GSA as part of that agency's responsibility to recommend improvements in records management practices and programs, under authority of 44 U.S.C. 2004 and 2006. Such disclosure shall be made in accordance with the GSA regulations governing inspection of records for this purpose, and any other relevant (i.e., GSA or Commerce) directive. Such disclosure shall not be used to make determinations about individuals
- 8. A record from this system of records may be disclosed, as a routine use, to the public after either publication of the application pursuant to 35 U.S.C. 122(b) or issuance of a patent pursuant to 35 U.S.C. 151. Further, a record may be disclosed, subject to the limitations of 37 CFR 1.14, as a routine use, to the public if the record was filed in an application which became abandoned or in which the proceedings were terminated and which application is referenced by either a published application, an application open to public inspection or an issued patent.
- A record from this system of records may be disclosed, as a routine use, to a Federal, State, or local law enforcement agency, if the USPTO becomes aware of a violation or potential violation of law or regulation.

	Application No.	Applicant(s)			
	10/595,384	HESS ET AL.			
Notice of Allowability	Examiner	Art Unit			
	DUNG LE	2818			
The MAILING DATE of this communication appe All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously malled). a Notice of Allowance (PTO-S) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RI of the Office or upon petition by the applicant. See 37 CFR 1.313 1. This communication is responsive to <u>application filed on 04</u> /	(OR REMAINS) CLOSED in this app or other appropriate communication GHTS. This application is subject to and MPEP 1308.	lication. If not included will be mailed in due course. THIS			
 An election was made by the applicant in response to a rest requirement and election have been incorporated into this action. 	riction requirement set forth during the	ne interview on; the restriction	on		
3. ☑ The allowed claim(s) is/are 1-42.					
4. ☑ Acknowledgment is made of a claim for foreign priority unde a) ☑ All b) ☐ Some* c) ☐ None of the: 1. ☐ Certified copies of the priority documents have					
Certified copies of the priority documents have	been received in Application No.				
Copies of the certified copies of the priority doc	cuments have been received in this	national stage application from the			
International Bureau (PCT Rule 17.2(a)).					
* Certified copies not received:					
Applicant has THREE MONTHS FROM THE "MAILING DATE" noted below. Failure to timely comply will result in ABANDONM THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.		complying with the requirements			
5. A SUBSTITUTE OATH OR DECLARATION must be submitted. Note the attached EXAMINER'S AMENDMENT or NOTICE OF INFORMAL PATENT APPLICATION (PTO-152) which gives reason(s) why the oath or declaration is deficient.					
6. CORRECTED DRAWINGS (as "replacement sheets") must	be submitted.				
(a) Including changes required by the Notice of Draftspers	on's Patent Drawing Review (PTO-	948) attached			
 hereto or 2) to Paper No./Mail Date 					
(b) ☐ including changes required by the attached Examiner's Paper No./Mail Date	s Amendment / Comment or in the O	ffice action of			
ldentifying indicia such as the application number (see 37 CFR 1. each sheet. Replacement sheet(s) should be labeled as such in tl					
 DEPOSIT OF and/or INFORMATION about the deposit of B attached Examiner's comment regarding REQUIREMENT FO 					
Attachment(s) 1. ☑ Notice of References Cited (PTO-892)	5. ☐ Notice of Informal P	atent Application			
2. ☐ Notice of Draftperson's Patent Drawing Review (PTO-948)	6. ☐ Interview Summary				
Information Disclosure Statements (PTO/SB/08),	Paper No./Mail Dat 7. Examiner's Amendn	e			
Paper No./Mail Date <u>08/15/2007</u> 4. ☐ Examiner's Comment Regarding Requirement for Deposit	8. Examiner's Stateme	nt of Reasons for Allowance			
of Biological Material	9. Other				
/DUNG A LE/					
Primary Examiner, Art Unit 2818					
U.S. Patent and Trademark Office					

U.S. Patent and Trademark Office PTOL-37 (Rev. 03-11)

DETAILED ACTION

Specification

The specification has been checked to the extent necessary to determine the presence of all possible minor errors. However, the applicant's cooperation is requested in correcting any errors of which applicant may become aware in the specification.

Reason for allowance

Claims 1-42 are allowed. The following is an examiner's statement of reason for allowance:

Set of claims 1-7 and 39: None of the references of record teaches or suggests the claimed test chip having the at least one level having an m x n array of regions, where m and n are integers, each region capable of including at least one test structure, at least some oft he regions including respective test structures, the level having m+1 driver lines oriented in a first direction, the m+1 driver lines connected to collectively provide input signals to all of the test structures, the level having 4n receiver lines arranged in a second direction, the 4n receiver lines connected to collectively receive output signals from all of the test structures, wherein the test structures are arranged and connected so that each of the structures can be individually addressed for testing using the m+1 driver lines and 4n receiver lines.

Set of claims 8-12 and 40: None of the references of record teaches or suggests the claimed Test chip, comprising: at least one level having an array of regions, each region capable of including at least one test structure, at least some of the regions including respective test structures, the level having a plurality of driver lines that provide input signals to the test structures, the level having a plurality of receiver lines that receive output signals from the test structure, the level having a plurality of devices for controlling current flow, wherein each test structure is connected to at least one of the driver lines with a first one of the devices therebetween, and each test structure is connected to at least one of the receiver lines with a second one of the devices therebetween, so that each of the test structures can be individually addressed for testing using the driver lines and receiver lines.

Set of claims 13-15 and 41: None of the references of record teaches or suggests the claimed test chip having at least one level having an array of regions with m columns and n rows, where m and n are integers, each region capable of including at least one test structure, at least some of the regions including respective test structures, the level having m+1 driver lines oriented in a first direction, with the m columns arranged between successive ones of the m+1 driver lines, each test structure having two inputs connected by respective diodes, transistors, or controlled switches to a respective two of the driver lines, the m+1 driver lines collectively providing input signals to all of the test structures, the level having 4n receiver lines oriented in a second direction, each of the n rows arranged between a respective first pair of the 4n receiver lines on a first side thereof and a respective second pair of the 4n receiver lines on a second side thereof, each test structure having first and second outputs connected by respective diodes,

transistors or controlled switches to respective ones of the receiver lines on the first and second side of that test structure, so that the 4n receiver lines collectively receive output signals from all of the test structures, whereby each of the structures can be individually addressed for testing.

Set of claims 16-22 and 42: None of the references of record teaches or suggests the claimed test chip comprising: at least one layer having n regions, where n an integer, each region capable of including at least one test structure, at least some of the regions including respective test structures, each comprising a nest of m parallel lines, where m is an integer, the at least one layer having m driver lines, the m driver lines connected to provide input signals to the respective m parallel lines in each nest, the at least one layer having at least 2n receiver lines, the at least 2n receiver lines connected to collectively receive output signals from all of the test structures, wherein the test structures are arranged and connected to the m driver lines and at least 2n receiver lines so that a presence of a short or open circuit defect in any of the nests can be identified.

Set of claims 23-28: None of the references of record teaches or suggests the claimed test method having the steps of (a) forming circuit paths for at least one level of a chip, the level having an m x n array of regions, where m and n are integers, at least some of the regions including respective test structures, (b) forming m+1 driver lines oriented in a first direction, each test structure being connected to at least one of the driver lines; (e) forming 4n receiver lines arranged in a second direction, each test structure being connected to at least one of the receiver Rues; (d) individually addressing all the test structures using the m+1 driver lines and 4n

receiver lines; and (e) providing input signals to all of the test structures using the m+1 driver lines, and (f) receiving output signals from all of the test structures using the 4n receiver lines.

Set of claims 29-37: None of the references of record teaches or suggests the claimed test method, comprising: (a) forming circuit paths for at least one layer having n regions, where n is an integer, each region capable of including at least one test structure, at least some of the regions including respective test structures, each comprising a nest of m parallel lines, where m is an integer, b) forming m driver lines for the at least one layer; (c) forming at least 2n receiver lines for the at least one layer; (d) providing input signals to the respective m parallel lines in each nest using the m driver lines; (e) measuring output signals from all of the test structures using the at least 2n receiver lines; and (f) identifying the presence of a short or open circuit defect in any of the nests based on the output signals received by way of the at least 2n receiver lines.

Independent claim 38: None of the references of record teaches or suggests the claimed test chip having at least one layer having a vector of regions, each region capable of including at least one test structure, at least some of the regions including respective test structures, the layer having a plurality of driver lines that provide input signals to the test structures, the layer having a plurality of receiver lines that receive output signals from the test structures, the layer having a plurality of devices for controlling current flow, wherein each test structure is connected to at least one of the driver lines with a first one of the devices therebetween, and each test structure is connected to at least one of the receiver lines with a second one of the devices therebetween, so

that each of the test structures can be individually addressed for testing using the driver lines and receiver lines.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance".

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Dung A. Le whose telephone number is (571) 272-1784. The examiner can normally be reached on Monday-Tuesday and Thursday 6:00am- 4:00 pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Stephen Loke can be reached on (571) 272-1657. The central fax phone numbers for the organization where this application or proceeding is assigned are (571)272-8300.

Information regarding the status of an application may be obtained from the Patent

Application Information Retrieval (PAIR) system. Status information for published applications

Application/Control Number: 10/595,384 Page 7

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may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

/DUNG A LE/ Primary Examiner, Art Unit 2818